Effects of Molecular Adsorption on the Electronic Structure of Single-Layer Graphene

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ABSTRACT: The interaction of small molecules (CCl4, CS2, H2O, and acetone) with single-layer graphene (SLG) has been studied under steady-state conditions using infrared multiple-internal-reflection spectroscopy. Adsorption results in a broad and intense absorption band, spanning the ∼200 to 500 meV range, which is attributed to electronic excitation. This effect, which has not previously been reported for SLG, has been further investigated using dispersion-corrected density functional theory to model the adsorption of H2O on SLG supported on an SiO2 substrate. However, the ideal and defect-free model does not reproduce the observed adsorption-induced electronic transition. This and other observations suggest that the effect is extrinsic, possibly the result of an adsorption-induced change in the in-plane strain, with important differences arising between species that form liquid-like layers under steady-state conditions and those that do not. Furthermore, the C–H stretching modes of CH2 groups, incorporated in the SLG as defects, undergo nonadiabatic coupling to the electronic transition. This leads to pronounced antiresonance effects in the line shapes, which are analyzed quantitatively. These results are useful in understanding environmental effects on graphene electronic structure and in demonstrating the use of the vibrational spectroscopy of H-containing defects in characterizing SLG structure.

1. INTRODUCTION

Changes in the electronic properties of single-wall carbon nanotubes (SWCNTs) and graphene, when brought into contact with molecular vapors, have long been recognized as a basis for chemical sensing and for doping. However, the mechanisms whereby these changes occur are in many cases not completely understood. In many interpretations, the substrate is described in terms appropriate to the Drude model for a free-electron gas. In this context, an electron donor or acceptor (e.g., NH3 or NO2, respectively) changes the density of free carriers and thereby the conductivity. For molecules with a significant dipole moment, a decrease in conductivity has been shown to result from scattering of free carriers by the dipolar electric field. Such phenomena are well documented in the case of adsorption on metals. Other processes, such as adsorbate-induced changes in the barrier height at the SWCNT/metal contact, have also been implicated.

In the present work, it will be shown that weak electron acceptors (CCl4, CS2, H2O) and donors (acetone), especially in condensed liquid-like layers, can have a pronounced effect on the electronic structure of single-layer graphene (SLG). This will be detected, using infrared (IR) spectroscopy under steady-state conditions, through observation of changes in the broad-band absorption due to electronic excitation and of the coupling of local vibrational modes with this continuum. The line shape of the narrow vibrational resonance is sensitive to damping via nonadiabatic coupling to the electronic continuum, the nature of which can change when SLG interacts with an adsorbate. The electronic effects reported here constitute a potential new transduction mechanism for chemical sensing as well as a framework for understanding environmental effects on the electronic properties of SLG.

Graphene layers were deposited on both sides of a lightly oxidized Si parallelepiped, configured for IR multiple-internal-reflection spectroscopy (MIRS), and characterized using X-ray photoelectron spectroscopy (XPS) and Raman spectroscopy. The MIRS technique permits detection of surface species with high sensitivity under steady-state conditions, which is necessary due to the weak bonding interaction between SLG and the species of interest. For this study, the samples were not annealed, unless otherwise stated, so that the graphene would as much as possible resemble a “free-standing” layer. Annealing graphene in contact with SiO2 has been shown to have pronounced effects on the chemical, physical, and electronic properties due to increased contact with the substrate.

2. EXPERIMENTAL DETAILS

2.1. IR Spectroscopy. The MIRS data were obtained using a Thermo Scientific 8700 Fourier-transform IR (FTIR) system with a liquid-N2-cooled “narrow-band” HgCd1–xTe (MCT-A) detector at a resolution of 4 cm–1. 1000 scans were averaged in about 8 min, and 2-fold zero-filling and triangle apodization were applied to the interferogram before transformation. Polarization, when used, was provided by a wire-grid/KRS-5 device. The substrate was a 25 × 15 × 1 mm3 float-zone (FZ) Si parallelepiped with a graphene film on both faces and an internal-reflection angle of θ = 60°. The use of FZ Si avoids the strong...
1106 cm\(^{-1}\) O impurity band found in Czochralski Si. High-resistivity Si was used, as is typical in IR MIRS, to avoid strong free-carrier absorption. \(\Theta\) was chosen to be much higher than the critical angle (\(\Theta_c \approx 17^\circ\) for Si in the mid-IR) for two reasons. First, although a high \(\Theta\) reduces somewhat the sensitivity to absorbing thin films,\(^{10}\) it also minimizes the total optical path length through the Si, thus moving the transmission cutoff to lower energy.\(^{11}\) Second, a high \(\Theta\) reduces the possibility of anomalous internal-reflection phenomena\(^{10}\) that can occur when \(\Theta\) is close to \(\Theta_c\). The accessible range was \(\sim 1000–7500\) cm\(^{-1}\), limited on the low end by the Si transmission and on the high end by the detector response. Note that the spectrometer low-pass filter and the sampling interval had to be set appropriately to pass Fourier frequencies above the standard 4000 cm\(^{-1}\) upper limit.

The substrate was mounted between two hollow blocks of Teflon and the whole assembly squeezed tightly together to form a vapor-tight seal around the edges of the Si. There were 11 internal reflections sampling graphene not in contact with Teflon. A stream of pure dry \(N_2\) was mixed with another stream of \(N_2\) saturated with the species of interest at the ambient-temperature vapor pressure \(P_0\). The desired partial pressure \((P/P_0)\) was obtained by adjusting the flow rates of the two streams, which were then mixed and allowed to flow continuously over both faces of the sample while MIRS data were recorded. The total flow rate (both streams) was about 100 mL/min, with a total cell volume of 5.3 mL. Spectra are presented in the form of \(\delta R/R\), the fractional change in reflectance per internal reflection caused by the introduction of the molecular species. The reference spectrum in all cases was obtained with pure \(N_2\) flowing through the cell. No smoothing or background correction was applied to any of the data.

Reagent-grade \(CCl_4\), \(CS_2\), and acetone and locally prepared deionized \(H_2O\) were used without further purification and were contained in fritted gas-washing bottles, or “bubblers”, through which dry \(N_2\) was flowed for preparation of the saturated \(N_2\) stream mentioned above. To check for impurities, the vapor stream exiting the Teflon cell could be directed through a 10 cm gas cell, with KBr windows, mounted in the FTIR sample compartment and the transmission spectrum compared to reference data. All liquids were degassed by purging with \(N_2\). The liquid reservoirs were all at nominal room temperature (25 \(^\circ\)C) except for \(CS_2\), which was maintained at 5 \(^\circ\)C. The vapor pressures at these temperatures are \(P_0 = 113, 158, 228, \) and 23 Torr, respectively, for \(CCl_4\), \(CS_2\), acetone, and \(H_2O\) based on published parameters\(^{12}\) (\(A, B\), and \(C\) for the Antoine equation \([\log_{10}(P_0) = A - B/(C + T)]\)).

2.2. X-ray Photoemission and Raman Spectroscopies. The XPS data were obtained using a Thermo Scientific K-Alpha system with a monochromated Al K\(\alpha\) source \((h\nu = 1486.6\) eV) and a hemispherical electron energy analyzer at a resolution of about 0.6 eV. The area sampled was 400 \(\mu\)m in diameter, and a flood gun was used for sample neutralization because the Si substrates used for MIRS are highly resistive. The BE was determined using a reference value\(^{13}\) of 99.34 eV for the elemental Si 2p\(1/2\) peak. The BE correction required was small, typically \(<0.1\) eV. The C 1s least-squares fits were done using a Gaussian-broadened Doniach–Sunjić (DS) function.\(^{15}\) The DS theory describes the screening of a photoionized core hole in a free-electron

3. RESULTS AND DISCUSSION

3.1. Sample Characterization. Figure 1a shows C 1s XPS data, which can be least-squares fitted with a single Gaussian-broadened Doniach–Sunjić (DS) function.\(^{15}\) The DS theory describes the screening of a photoionized core hole in a free-electron
metal, which results in a distorted Lorentzian line shape with a tail extending to higher binding energy (BE). The DS function is only approximately accurate in the case of graphene, which is a semimetal. Nevertheless, the fit shows only sp$^2$-hybridized C (BE = 284.5 eV) with little or no evidence of sp$^3$-hybridized C or of C–O bonds (as in C–O–C or C–OH groups). Such species would result in satellites$^{17}$ higher in BE by about 0.5 or 1.8 eV, respectively, than the sp$^3$ C 1s peak. The DS asymmetry parameter ($\alpha = 0.13$) agrees very well with the result ($\alpha = 0.125$) for bulk highly oriented pyrolytic graphite (HOPG). This sample, henceforth referred to as “G1” (for “graphene sample no. 1”), exhibited a C 1s intensity that was spatially uniform ($\pm 10\%$) over most of both sides of the MIRS substrate, indicating a minimal density of holes (i.e., exposed SiO$_2$).

Another sample (G2, Figure 1b) showed a weak satellite at 1.90 eV higher BE, with an integrated intensity equal to a few percent of that of the graphene peak, which indicates a small concentration of sp$^3$ C–O bonds. There is also evidence in the residual spectrum of structure near 288 eV due to C=O bonds.$^{17}$ Some areas showed about the same C 1s intensity as did sample G1, but others showed a much smaller intensity, indicating holes in the graphene layer. A slightly larger DS asymmetry ($\alpha = 0.17$) was needed to fit the graphene peak, which suggests the presence of a weak and unresolved sp$^3$ component at slightly higher BE.

Comparison of data for samples with different degrees of perfection will be useful in the following discussion. In all, five different SLG and three multilayer graphene samples were studied, and two of the SLG samples were subjected to annealing (to be discussed later), giving in effect a total of 10 samples. The XPS data in Figure 1 are representative of all of these samples. Analysis of the Si 2p XPS, described in section 1 of the Supporting Information, indicates an oxide layer underlying the graphene with a thickness in the range of 19 nm, which results in a distorted Lorentzian line shape with a tail extending to higher binding energy (BE). The DS function in SLG, will be discussed later in connection with MIRS data for few-layer graphene (FLG).

3.2. IR Spectroscopy Results – Overview and Electronic Excitation.

In this section, the general IR-spectroscopic results are described, and the adsorption-induced electronic excitation is examined. Figure 2 shows MIRS data (sample G1) for acetone, H$_2$O, and CCl$_4$ (all at $P/P_0 = 1.0$). All spectra are shown on the same $\delta R/R$ scale (normalized to the total number of internal reflections) and without any arbitrary vertical displacement. The dashed line shows the position of $\delta R/R = 0$. The increased noise at the high-energy end is due to decreasing detector sensitivity. The intense acetone $\nu(C=O)$ peak at 1715 cm$^{-1}$ has been truncated for clarity of display. The structure at the low-energy end, near 1450 cm$^{-1}$, results from a strong multiphonon absorption peak in the Si substrate that does not completely cancel in $\delta R/R$. The weak feature labeled “$\nu(C(O)=O)$” is due to an impurity discussed in the text. Note that an increase in absorption corresponds to downward-pointing peaks.

The weak feature at the extreme low-energy end of all spectra ($\sim 1450$ cm$^{-1}$) is due to a strong Si multiphonon absorption that does not completely cancel in the ratio of single-beam spectra. A very weak structure, most noticeable in the p-polarized CCl$_4$ spectrum, is seen near 1700 cm$^{-1}$ and is thought to arise from a perturbation of the $\nu(C=O)$ mode$^{20}$ of carbonyl impurities by interaction with the liquid multilayer. Although such species are at or below the XPS detection limit ($\sim 1\%$ of the graphene C 1s intensity, cf. Figure 1), they may be detectable in MIRS due to the large oscillator strength of this mode. However, there is no indication of the $\nu(C=C)$ stretching mode, which, for defect-free SLG, is IR-forbidden$^{21}$ and not detected in transmission spectra.$^{20}$ This mode, which produces the Raman-active G-band found at 1588 cm$^{-1}$ in SLG, will be discussed later in connection with MIRS data for few-layer graphene (FLG).

The features of interest in the present work are the very intense and broad absorption bands spanning the $\sim 1600–4000$ cm$^{-1}$ (200–500 meV) range and the unusual line shapes seen in the $\nu(C–H)$ stretching region ($\sim 2850–2950$ cm$^{-1}$). Purging with dry N$_2$ at room temperature, following exposure to any of the species studied here, eventually removes these features. This indicates that they are not due to covalent bonding between the reagents and either graphene or the SiO$_2$ underlayer. Rather, these effects are reversible at room temperature and are observable only under steady-state conditions. Numerical simulation of the MIRS experiment (Supporting Information, section 5) shows that they do not arise from thin-film optical effects,$^{22}$ and none of these effects were observed in “blank” experiments for which no graphene was deposited on the oxidized Si surface (Supporting Information, section 6). The blank sample was processed using the same procedure as for the graphene samples including the use, and subsequent removal, of PMMA as described above (section 2.3).
Further observations regarding the blank sample are given in the Supporting Information, sections 2 and 6.

Data obtained in the range of $0.1 \leq P/P_0 \leq 1.0$ (not shown) indicate absorption intensities that increase with $P/P_0$. The absorption spectrum of ideal SLG does not exhibit any structure in this energy region. It has been shown that movement of the Fermi level ($E_F$) in bilayer graphene (BLG) or in FLG by electron transfer to or from an adsorbate or by application of an electric field can change the nature of the interband spectrum in the mid-IR. However, the interband transitions in BLG and FLG, which are modified by these perturbations, are not found in pristine SLG. Hence, the mechanisms discussed in refs 24–28 are not believed to be directly applicable to the present data. A subsequent section will discuss the effect of doping on the MIRS data; however, doping (i.e., a shift in $E_F$) cannot by itself account for the appearance of a mid-IR absorption band in SLG. The Supporting Information, section 7, discusses similar data for sample G2, which has known imperfections as mentioned above. The spectra are quantitatively different, although broad-band absorptions and $\nu(C-H)$ line shape anomalies are again present for all three adsorbates. For all samples, the intensity of the broad-band absorption consistently varies as CCl$_4$ < H$_2$O < acetone.

Numerical evaluation of the IR electric field throughout the MIRS sample (Supporting Information, section 8) shows that the intensity of the surface-normal component of the $p$-polarized field, is small within the graphene layer and that the in-plane field intensities, $E_{p,\parallel}$ and $E_{p,\perp}$, are relatively large and nearly equal. Hence, the dynamic dipole moment associated with the electronic excitation must lie in the SLG plane. Given the symmetry of ideal SLG, one then expects the $s$- and $p$-polarized spectra to be identical, which is not the case. This could be an indication of in-plane strain, which is found in theoretical work to have a pronounced effect on the electronic structure of SLG. For certain directions, the effect of strain on the density of states (DOS) is particularly apparent near $E_F$, within the energy range studied here. Furthermore, the extent of the $\pi$ polarization dependence seen experimentally varies from sample to sample, which is consistent with an extrinsic effect such as strain. Hence, a change in strain due to contact with the liquid-like layer is tentatively suggested as a possible mechanism giving rise to the electronic absorption band. Buckling, or corrugation, is another well-known extrinsic effect in SLG supported on SiO$_2$ (e.g., refs 9,31). However, this is found not to affect the DOS near $E_F$ except in extreme cases.

3.3. Computational Model. In this section, we consider whether the observed electronic absorption can be explained in terms of ideal SLG supported on SiO$_2$, using H$_2$O as the simplest adsorbate and one which is observed (Figure 2) to give a pronounced effect. There is also a body of prior theoretical work for H$_2$O/SLG with which to compare the present results. It has previously been proposed that dangling-bond defects on the SiO$_2$ surface are important in the response to adsorbates for SLG supported on SiO$_2$. However, any such highly reactive defects on air-exposed SiO$_2$ would be passivated by dissociative adsorption of H$_2$O vapor to form OH groups and would not, therefore, be expected at a real graphene–SiO$_2$ interface.

Some density functional theory (DFT) treatments of H$_2$O on free-standing SLG have employed methods that do not completely account for dispersion (i.e., noncovalent or van der Waals interaction), which is expected to be a major factor in this system. The adsorption energies ($\Delta E_{ads}$) found in these studies, which are determined the effect due to H$_2$O was seen in the DOS (not corrected for basis set superposition error (BSSE), was found. The lack of a BSSE correction, which would reduce the magnitude of $\Delta E_{ads}$, makes it difficult to compare this result with previous reports. However, without dispersion, no binding ($\Delta E_{ads} \approx 0$) was found, confirming the importance of including this effect. In this preliminary study, we have not determined the effect of higher H$_2$O coverages. Even with dispersion, no effect due to H$_2$O was seen in the DOS (not shown) within $\sim 1.5$ eV of $E_F$. Also, no doping was observed, in the form of a shift of $E_F$ into the valence or conduction band, because this appears only for an H$_2$O multilayer with ice-like ordering.
multiplied by a factor of 3, and different spectra have been displaced vertically for clarity.

Following ref 33, SiO2 was included using a slab (Figure 3b) derived from the (111) surface of β-cristobalite with dangling Si bonds terminated in OH. The lattice constant of β-cristobalite is \( a_0 = 7.16 \text{ Å} \); hence, that of the (111) surface unit cell \((a_0/\sqrt{2})\) is only \( \sim 2.7\% \) larger than twice that of graphite. Thus, a \((2 \times 2)\) SLG supercell is commensurate with a slightly compressed β-cristobalite (111) surface. Previous work33 (omitting dispersion) for SLG interacting with defect-free SiO2 reported no significant effects in the vicinity of the SLG Fermi level, and the present results concur with this finding. The present work allows an estimate of the energy of adhesion between SLG and SiO2 as \( \Gamma = 320 \text{ meV/H}_2\text{O} \), which can be compared to a value of about \( 0.50 \text{ eV/nm}^2 \) \((80 \text{ mJ/m}^2)\) obtained40 for vitreous SiO2 and graphite using molecular mechanics with a parametrized force field.

The next step is to add H2O to the SiO2-supported SLG. In the relaxed structure (Figure 3b), H2O lies nearly flat, with \( \Delta E_{\text{ads}} = 257 \text{ meV/H}_2\text{O} \). The difference of 50 meV/H2O in \( \Delta E_{\text{ads}} \) from that for free-standing SLG given above should be essentially unaffected by BSSE. Thus, the underlying SiO2 slightly enhances the adsorption of H2O; however, there is again no effect on the DOS near \( E_F \). It is concluded that pristine SLG is weakly hydrophilic but that the MIRS results cannot be explained simply in terms of an ideal H2O/SLG/SiO2 structure and that some extrinsic effect, such as strain, is needed to account for the data.

3.4. IR Spectroscopy Results — Vibrational Line Shapes and Fine Structure. We now proceed to the anomalous \( \nu(C-H) \) line shapes. Figure 4 shows the same data as in Figure 2 but focusing on the C–H stretching region. All three adsorbates gave similar features near 2920 and 2850 cm\(^{-1}\), although they are relatively weak in the case of H2O. A reason for the small effect of H2O will be suggested in the following section. These features are reproducible for all 10 samples, and spectra obtained at 2 cm\(^{-1}\) (vs 4 cm\(^{-1}\)) resolution showed a negligible reduction in line width, indicating that the data are not resolution limited. The higher-energy feature is essentially independent of polarization, whereas the lower-energy component is stronger in p-polarization.

However, in the case of H2O, the very weak \( \nu(C-H) \) structure does show a polarization dependence, being almost undetectable in s-polarization. Additional structure is seen for acetone near 3000 cm\(^{-1}\) due to the molecular \( \nu(C-H) \) modes. It should be noted that the graphene was not intentionally hydrogenated; hence, the \( \nu(C-H) \) modes are due to defects and/or edge sites.

The following discussion will focus on the CCl4 results because CCl4 presents no interfering absorption bands in the region of interest and is “inert” in the sense of having no dipole moment and only a weak interaction with graphene-like materials. The next step is to add H2O to the SiO2-supported SLG. In the relaxed structure (Figure 3b), H2O lies nearly flat, with \( \Delta E_{\text{ads}} = 257 \text{ meV/H}_2\text{O} \). The difference of 50 meV/H2O in \( \Delta E_{\text{ads}} \) from that for free-standing SLG given above should be essentially unaffected by BSSE. Thus, the underlying SiO2 slightly enhances the adsorption of H2O; however, there is again no effect on the DOS near \( E_F \). It is concluded that pristine SLG is weakly hydrophilic but that the MIRS results cannot be explained simply in terms of an ideal H2O/SLG/SiO2 structure and that some extrinsic effect, such as strain, is needed to account for the data.

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Figure 4. Similar to Figure 2 but showing the \( \nu(C-H) \) region. The \( \delta R/R \) scale applies to the acetone and CCl4 data. The H2O spectra have been multiplied by a factor of 3, and different spectra have been displaced vertically for clarity.

Figure 5. (Top) Data obtained under steady-state exposure to (a) CCl4 and (b) CS2 at \( P_0 = 99 \text{ Torr (22 °C)} \) and 158 Torr (5 °C), respectively, with an unpolarized IR beam. The data were obtained for sample G2, and the spectra have been displaced vertically for clarity. The weak structure near 3700 cm\(^{-1}\) is a baseline artifact. (Bottom) Least-squares fit of eq 1 to an s-polarized CCl4 spectrum. The points are the raw data, after subtraction of the fitted polynomial background, and the solid line is the fit. Note the different energy scales in the upper and lower panels. The fitting parameters are: \( \nu_0 = 2918 \text{ cm}^{-1}, \nu_{	ext{as}} = -3.49, \Gamma_G = 4.6 \text{ cm}^{-1}, \Gamma_L = 4.7 \text{ cm}^{-1} \); and \( \nu_0 = 2844 \text{ cm}^{-1}, \nu_{	ext{as}} = -0.01, \Gamma_G = 5.3 \text{ cm}^{-1}, \Gamma_L = 4.2 \text{ cm}^{-1} \). The inset shows a configuration of the CH2 that is consistent with the different \( \nu_{	ext{as}} \) results (see text). The dashed lines show the IR beam, and the s- and p-vectors define the polarizations. \( \mu_s, \mu_{ps}, \mu_e \) depict the vibrational and electronic DDMs. The rotation of the CH2 about the surface normal is arbitrary; hence, \( \nu_s \) can be excited only by the surface-normal component in p-polarization, but \( \nu_{ps} \) can be excited by s-polarization and by the in-plane component in p-polarization.
to CS$_2$, another small, nonpolar molecule with no C–H bonds. The results are clearly very similar. These data were obtained for sample G2 and are in good agreement with the CCl$_4$ data for sample G1 (Figure 2). As mentioned above (section 2.3), unsuccessful attempts were made to incorporate D using CD$_3$F and D$_2$ in place of CH$_4$ and H$_2$ in the growth. However, it was later determined that nondeuterated hydrocarbons were also present in the growth ambient and were possibly the source of the persistent CH$_4$ species. Hence, it cannot yet be determined at what point in the sample growth and preparation the C–H bonds are formed. Because the CH$_4$ groups involve sp$^3$ sites, a firm upper limit of $\sim 0.1$ is estimated for the CH$_4$/total-C atomic ratio, based on the maximum possible sp$^3$/sp$^2$ ratio in the C 1s XPS (Supporting Information, section 2).

The energies of the 2850 and 2920 cm$^{-1}$ peaks are consistent with, respectively, the symmetric (in-phase, $\nu_s$) and asymmetric (out-of-phase, $\nu_d$) C–H stretching modes of an sp$^3$-hybridized CH$_2$ group, which would be a defect in SLG. The line shape of the $\nu_d$(CH$_2$) mode is unusual, being distorted and inverted or derivative-like in appearance. This effect is much less pronounced, and may even be absent, in the $\nu_s$(CH$_2$) mode. The anomalous line shape results from the coupling of the vibrational mode to the electronic excitation continuum. The theory for this effect (termed “antiresonance”, “vibrionic interference”, or “the Fano effect”) was developed in the context of adsorbate vibrational spectra by Langreth et al.$^{43,44}$ and reviewed from an experimental perspective by Chabal.$^{45}$ The dynamic dipole function, and all terms were unconstrained in the fitting results. It is not clear whether

$$\text{Im}[\alpha(\nu)] = \frac{\nu \mu^2}{\pi} \left[ \Gamma_L + \nu \Gamma_L \left( 1 - \nu^2 \tau^2 - 2 \nu \tau (\nu^2 - \nu_0^2) \right) \right]$$

which, for $\tau = 0$, reduces to the Lorentzian line shape. Here, $\alpha(\nu)$ is the local polarizability, $\Gamma_L$ is the Lorentzian line width, and all other terms have been defined previously. An s-polarized spectrum was used because the relative intensity of the lower-energy $\nu_s$ peak is weaker than in p-polarization, which simplifies the fit. The fitting is made difficult by the presence of overlapping weak and poorly resolved structure due to overtones of the $\delta$(C–H) bending modes$^{42}$ and to the stretching modes of other C–H sites, which are not included in the fit. Evidence for the existence of other C–H sites will be given below. $\alpha(\nu)$ was convoluted with a Gaussian (full-width at half-maximum, FWHM, $=\Gamma_G$) to include inhomogeneous broadening and finite spectrometer resolution, both approximated as Gaussians. To this was added a cubic or quartic polynomial background function, and all terms were unconstrained in the fit.

The $\Gamma_G$ values (given in the figure caption) are about the same for both peaks, as are the two $\Gamma_L$ values. Subtracting the FTIR resolution (4 cm$^{-1}$) in quadrature from $\Gamma_G$ gives an inhomogeneous broadening of about 2.3 (3.5) cm$^{-1}$ for the $\nu_{as}$ ($\nu_s$) mode. The main difference is in $\nu_{as}$, a dimensionless asymmetry parameter that reflects the strength of the coupling between the electronic and vibrational excitations and that is large for the 2918 cm$^{-1}$ $\nu_{as}$ mode and small for the 2844 cm$^{-1}$ $\nu_s$. Fits to other data sets give somewhat different results for $\nu_{as}$, but the value for $\nu_{as}$ ($\nu_s$) is always in the range of $-2.0$ to $-3.5$. For comparison, $\nu_{as}$ in the range of $-1.6$ to +0.54 has been found$^{46,47}$ for adsorbates on metals. The Supporting Information, section 10, shows how the line shape changes over a range of $\nu_{as}$ values and how these shapes replicate those seen in Figure 4.

The DDM of $\nu_s$ is parallel to the 2-fold (C$_2$) axis of the CH$_2$ group, whereas that of $\nu_{as}$ is perpendicular to the C$_2$ axis and lies in the CH$_2$ plane. Figure 5 (inset) shows a configuration in which the CH$_2$ bridges two C atoms and lies above the SLG plane and which is consistent with the fitting results. It is not clear whether the CH$_2$ exists as a strained, cyclopropane-like structure or forms as a result of buckling of the graphene plane in response to the breaking of C=C bonds. Here, the $\nu_s$ DDM is normal to the
surface and therefore unable to couple to $\mu_{\omega}$ whereas the $\nu_{\omega}$ DDM can interact strongly. Deviations from this geometry in which the $\nu_{\omega}$ DDM has a finite projection on the SLG plane will increase (decrease) the magnitude of $\nu_{\omega}R$ for $\nu_{s}$ ($\nu_{p}$). In this model, $\nu_{s}(\text{CH}_2)$ is completely p-polarized. However, the observed $\nu_{s}/\nu_{p}$ relative intensity is about 1/3 (2/3) in s-(p-)polarization, not corrected for the relative magnitudes of the different components of the evanescent electric field (Supporting Information, section 8). The fact that $\nu_{s}(\text{CH}_2)$ is not completely p-polarized (i.e., $\nu_{s}/\nu_{p}$ is nonzero in s-polarization) constitutes an apparent violation of the selection rule for this geometry. This could result from the buckling9,31 (or corrugation) of SLG supported on SiO$_2$, which would tip the C$_2$ axis away from the z-axis, as described in the Supporting Information, section 11.

A recent study,48 using sum-frequency generation (SFG), reported the vibrational spectrum of individual H atoms chemisorbed as sp$^3$ C–H groups on pristine SLG grown in situ in an ultrahigh vacuum on an Ir(111) surface. Because the s-polarized IR electric field is suppressed at the vacuum/metal surface,45 only modes with a DDM normal to the surface were detected. These were superimposed on a broad continuum due to electronic excitation in the metal. This excitation (which is nonresonant with, and therefore does not couple to, the vibrational modes) is caused by the visible laser used in SFG. Antiresonance would still be possible, in principle, if the IR laser were to excite an electronic transition in the SLG at the frequency of a C–H stretching mode. However, no coupling was observed, which is consistent with the present results. In the experimental configuration used in ref 48, the SLG is in effect a metallic layer on a metallic substrate, and the DDM due to any IR-active electronic excitation within the SLG (or the Ir) would lie parallel to the surface$^{45–47}$ and, therefore, orthogonal to the DMM of the observed C–H modes. It is also noted that the observed SFG frequencies (2563 and 2716 cm$^{-1}$, respectively, for ortho and para C–H pairs) are much lower than the frequencies of the CH$_2$ defect sites seen here.

The effects on the $\nu$(C–H) spectrum of annealing are now considered briefly. Temperature-programmed desorption (TPD) studies$^{38}$ of H on carbon nanosheets show several H$_2$ peaks from $\sim$450 to 1100 K, indicating a variety of different adsorption sites and bonding configurations. Because similar TPD data for low coverages of H on SLG are, to our knowledge, unavailable, the nanosheet results are used as a guide. Annealing at 423 K (i.e., just below the desorption onset$^{38}$) in flowing Ar had no significant effect on the $\nu$(C–H) spectrum (not shown). However, annealing at 673 K, which decomposes some nanosheet sp$^3$ C–H sites, caused major changes as shown in Figure 6. In addition to the overall loss in intensity, indicating removal of C–H bonds, there is a slight shift of both modes to higher energy.

A major effect is seen in $\nu_{s}(\text{CH}_2)$, which now exhibits a strongly antiresonant (inverted) line shape resembling that of $\nu_{as}(\text{CH}_2)$. This, and the fact that $\nu_{s}(\text{CH}_2)$ is independent of IR polarization after annealing (not shown), indicates that the remaining CH$_2$ has the DDMs of both $\nu_{s}(\text{C–H})$ modes lying in the SLG plane. This accounts for the lack of polarization dependence, because both modes can now be excited by both $E_{\text{par}}$ and $E_{\text{axi}}$ (Supporting Information, section 8), and for the strong coupling of both modes to the electronic DDM. Figure 6 (inset) shows the implicit structure schematically. An in-plane sp$^3$ (tetrahedral) CH$_2$ group is difficult to envision in SLG; hence, we are led to consider a structure like a terminal C≡CH$_2$ group, which might occur at a vacancy or domain boundary in the SLG or at the periphery of the small BLG patches that are known to exist in these samples. However, in organic molecules, $\nu$(C–H) for such species typically falls above $\sim$3050 cm$^{-1}$. Hence, the structure after annealing cannot yet be assigned conclusively. There may also be an effect resulting from the increased contact$^2$ between graphene and SiO$_2$ after annealing.

Again using the nanosheet H$_2$ TPD results$^{49}$ as a guide, we assume that the species remaining after the 673 K anneal are also present, in the same chemical state and in the same concentration, before annealing. We then subtract the spectrum after annealing from that recorded before annealing to obtain the difference, shown in Figure 6c, which represents the spectrum of the sp$^3$ CH$_2$ species removed by annealing. This is qualitatively similar to the fitted line shape shown in Figure 5, which exhibits a “normal” $\nu_{s}$ and a strongly antiresonant $\nu_{as}$ mode. In this context, small sample-to-sample variations in the exact C–H line shapes, which are evident in comparing Figures 4–6, can be understood in terms of varying relative contributions from different C–H bonding configurations.

As a final comment, we have considered (Supporting Information, section 12) the possibility of an electrostatic contribution to the observed antiresonance line shapes arising from a coupling between the $\nu$(C–H) dynamic dipole and the dipole induced in a polarizable adsorbate such as CCl$_4$. The conclusion is that such an effect cannot account for the observed line shapes.

3.5. Additional Experiments. In an effort to understand better the effects reported above, we now discuss three further experiments involving (i) analyte desorption, (ii) multilayer (>1 layer) graphene films, and (iii) the effect of doping.

Figure 7 shows MIRS data versus elapsed time during N$_2$ purging after exposure to acetone vapor at P/P$_{eq}$ = 1.0. Acetone was selected because it gives an intense electronic absorption band and because the $\nu$(C=O) mode is sensitive to the molecular environment.60 The acetone modes, the $\nu$(C–H) features, and a large part of the electronic absorption band all vanish within $\Delta t$ = 1 min, which is the maximum attainable time resolution in the present experiment. The remaining features are a weakened
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Figure 7. $\Delta R/R$ (unpolarized) versus elapsed time ($\Delta t$) during purging with pure N$_2$ after exposure to acetone vapor at $P/P_0 = 1.0$. Only 100 scans in ~50 s were averaged, and $\Delta t$ is the elapsed time at the end of the data collection. The $\Delta t = 0$ spectrum was recorded prior to shutting off the acetone flow. The inset shows $\nu(C=O)$ at two different times. The feature appearing near 1450 cm$^{-1}$, with nearly constant intensity in all spectra, is a miscanceled Si multiphonon absorption.

The above discussion suggests a reason for why the $\nu(C=\cdot H)$ structure (Figures 2 and 4) is relatively weak for H$_2$O, even though an electronic absorption is clearly evident. If regions with sp$^3$-hybridized C–H bonds are highly hydrophobic, they would not be wetted to the same extent as the rest of the SLG, even at $P/P_0 = 1.0$, and would remain essentially unaffected by the H$_2$O.

Pristine regions are weakly hydrophilic, as shown by the dispersion-corrected DFT results described above, and would be wetted at elevated $P/P_0$.

Figure 8 shows the effects of increasing the graphene thickness, which permits an assessment of the importance of the small BLG regions found in the present SLG samples (Supporting Information, section 3) and also facilitates comparison with previous results. The fine structure, which is not clear in Figure 8, is shown in detail in the Supporting Information, section 14. Several points are noteworthy. First, the C=O stretching mode at about 1580 cm$^{-1}$ is IR-forbidden$^{21}$ in SLG and not detectable in the present SLG data. However, it is IR-allowed in BLG and FLG and is clearly observed here for samples with increased bilayer coverage. This feature shows a clear antiresonant line shape, as in previous work,$^{24-27}$ although the sign of the asymmetry differs from that in some studies.$^{24,27}$ The $\nu(C=O)$ mode also shows a clear antiresonance. In both cases, the dynamic dipole lies in the graphene plane, which permits coupling to electronic excitations as discussed above. Second, the C–H stretching modes become weaker with increasing thickness. This is consistent with previous results$^{24}$ in which no graphene C–H modes were seen for 3–4-layer films. Because the line shapes do not change significantly, one concludes that the degree of coupling to the electronic continuum is essentially constant and that, therefore, the loss of intensity is due to a real decrease in the number of C–H bonds per unit area.

Third, the overall shapes of the broad-band absorptions for samples with significant BLG coverage are distinctly different from that seen for SLG. For ~40% BLG, an intense and

Figure 8. Data for graphene layers of varying thickness. (a) SLG, typical of the samples used in the present work, with <5% of the area covered with bilayer regions; (b) an SLG layer with a ~20% of the area covered with bilayer regions; and (c) an SLG layer with ~40% bilayer regions. All data were obtained in p-polarization in CCl$_4$ vapor at $P/P_0 = 1.0$. The dashed line shows $\Delta R/R = 0$. The spectra are shown as recorded, with no displacement. Spectrum (a) is the same as that shown in Figure 2. The weak, unlabeled feature at the extreme low-energy end of (a) and (b) is a miscanceled Si multiphonon absorption.
well-defined band is seen at \( \sim 3030 \text{ cm}^{-1} \) (0.38 eV) with a FWHM of \( \sim 0.07 \) eV, which corresponds closely to the prominent mid-IR absorption band found in transmission spectra of well-formed BLG. Simulation (Supporting Information, section 5) shows that the appearance of this feature in \( \partial R/R \) is an optical effect resulting from the influence of the CCl\(_4\) layer on the MIRS “effective thickness” of the graphene layer. This feature is weak in the \( \sim 20\% \) bilayer sample, for which the second layer is more fragmented and incomplete, and is absent in SLG. Thus, it is concluded that the small coverage of CCl\(_4\) patches found in the SLG samples has no significant effect on the present results.

Finally, the data in Figure 9 show that doping is not, in itself, a major contributor to the effects observed here. For another \( \sim 20\% \) BLG sample, NH\(_3\) (an n-type dopant) leads to a very intense absorption band with a maximum at \( \sim 0.48-0.58 \) eV. After a total exposure of \( \sim 220 \) min to 0.1% NH\(_3\) in N\(_2\), the growth of this band had slowed but not yet stopped. The \( \sim 20\% \) BLG film used here is similar to that employed in Figure 8, and the CCl\(_4\) spectrum (Figure 9a) is also similar to that in Figure 8a. The antiresonant \( \nu(C=\equiv C) \) mode gains intensity with increasing NH\(_3\) coverage, and a broad, inverted band is seen at \( \sim 3430 \text{ cm}^{-1} \), which is ascribed to displacement of H\(_2\)O from the graphene/SiO\(_2\) interface by NH\(_3\) (Supporting Information, section 13). The NH\(_3\) itself is not detected, presumably due to a low coverage under these conditions. The broad-band feature seen for NH\(_3\) is different from that observed for CCl\(_4\) and leads to no detectable C–H features. Purging the NH\(_3\)/N\(_2\) with CCl\(_4\)/N\(_2\) at \( P/P_0 = 1.0 \) leads to the immediate appearance of the C–H features but with only a small reduction in the broad-band intensity. Further purging with saturated CCl\(_4\)/N\(_2\) for a total of 45 min (not shown) caused only a small additional decrease in the broad-band intensity.

\( \text{NH}_3 \) bonds only very weakly to HOPG and does not form a liquid-like layer at room temperature under the present conditions. The continued growth of the broad-band absorption over a period of several hours in a constant background of 0.1% NH\(_3\) in N\(_2\) shows the slow reversal of the NH\(_3\) effect during purging (vs the behavior of acetone, Figure 7), and the displacement of interfacial H\(_2\)O all indicate that NH\(_3\) diffuses into the space between graphene and SiO\(_2\). This has already been shown on the basis of the NH\(_3\) response of a graphene/SiO\(_2\) field-effect transistor. Interfacial NH\(_3\) is able to bond strongly to Si–OH via an O–H hydrogen bond, leaving the nonbonding N lone-pair orbital free to donate charge to the graphene. It does not, however, form a “wetting” layer on the exposed graphene surface, as do the other small molecules studied here, and does not affect the graphene electronic structure in the same manner as do these other adsorbates.

4. CONCLUSIONS

The interaction of small molecules (CCl\(_4\), C\(_2\)H\(_2\), H\(_2\)O, and acetone) with SLG has been observed under steady-state conditions using IR MIRS. The major results, most of which have not previously been reported, are as follows.

1. A broad and intense absorption band, spanning the range of roughly 200–500 meV, is seen as a result of exposure and is ascribed to an electronic excitation resulting from a modification of the SLG band structure near \( E_F \). The qualitative appearance of this feature and its dependence on IR polarization vary somewhat from sample to sample, which suggests an extrinsic effect such as adsorption-induced strain. However, it is seen for all samples studied here and increases in intensity as CCl\(_4\) < H\(_2\)O < acetone.

2. In an effort to identify the source of the electronic absorption band, ab initio DFT calculations have been performed to model the interaction of H\(_2\)O with SLG with and without an SiO\(_2\) substrate. In agreement with previous work, proper treatment of dispersion (i.e., van der Waals interaction) is found to be important in obtaining the adsorption energy. An adhesion energy of \( \sim 1.5 \text{ eV/nm}^2 \) is found for the SLG/SiO\(_2\) interface, and the configuration of the adsorbed H\(_2\)O is found to be vertical for free-standing SLG but nearly flat for SLG/SiO\(_2\). It is found, however, that the electronic absorption effects seen here cannot be understood in terms of an ideal H\(_2\)O/SLG/SiO\(_2\) structure.

3. Nonadiabatic coupling is observed between C–H stretching vibrations and the absorption-induced electronic excitation. This leads to a complex antiresonance line shape for the \( \nu_{as}(\text{CH}_2) \), and to some extent the \( \nu_s(\text{CH}_3) \), mode of CH\(_3\) groups present as defects in the SLG. On the other hand, vibrational modes of weakly adsorbed molecular species do not undergo this coupling and thus exhibit no line shape anomalies. Hence, the vibrating species must be an integral part of the SLG lattice for strong coupling to occur. A linkage exists between the strength of the coupling and the dependence of the mode intensity on IR polarization because both are related to the orientation of the dynamic dipole moment with respect to the SLG plane. Thus, the effect of annealing on the polarization and line shapes of the \( \nu(C–H) \) modes provides indirect evidence of restructuring of the SLG.

Figure 9. Data showing the effect of a strong, but noncondensable, dopant (NH\(_3\)) on a \( \sim 20\% \) bilayer sample. Trace (a) shows, for reference, data for CCl\(_4\) at \( P/P_0 = 1.0 \) as in previous figures. Traces (b)–(d) show data recorded, after completely purging the CCl\(_4\) with pure N\(_2\) in a 100 mL/min flow of 0.1% NH\(_3\) in N\(_2\). The approximate total exposure times are (b) 4, (c) 60, and (d) 220 min. Trace (e) shows the effect of purging the NH\(_3\)/N\(_2\) following (d), with CCl\(_4\)/N\(_2\) at \( P/P_0 = 1.0 \). The spectra were recorded in p-polarization and have not been displaced vertically. The dashed line shows \( \partial R/R = 0 \), and the encircled, upward-pointing band is due to the displacement of H\(_2\)O by NH\(_3\) (see text).
These results, although not yet fully understood, are potentially useful in several respects. The effects of weakly adsorbed small molecules on the SLG electronic structure could provide a protocol for the chemical modification of SLG electronic properties, for understanding environmental effects on these properties, and for transduction in SLG chemical sensors. The vibrational modes of adsorbed H$_2$, as seen in IR spectroscopy, have long been used to probe semiconductor surface structure, particularly under steady-state conditions during chemical processing. With the added dimension of nonadiabatic coupling to the adsorption-induced electronic excitations, $\nu(C-H)$ modes are potentially of value as sensitive indicators of changes in SLG physical and electronic structure during treatment.

**ASSOCIATED CONTENT**


**REFERENCES**


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